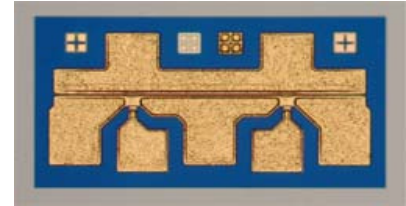


Low Noise and Medium Power GaAs FETs

FEATURES

- Low Noise Figure: NF = 0.5 dB Typical at 12 GHz
- High Associated Gain: G_a = 12 dB Typical at 12 GHz
- High Dynamic Range: 1 dB Compression Power P_{1dB} = 21.5 dBm at 12 GHz
- Breakdown Voltage: $BV_{DGO} \geq 9$ V
- $L_g = 0.25 \mu m$, $W_g = 300 \mu m$
- All-Gold Metallization for High Reliability
- Tight V_p ranges control
- High RF input power handling capability
- 100 % DC Tested

PHOTO ENLARGEMENT



DESCRIPTION

The TC1201 is a GaAs Pseudomorphic High Electron Mobility Transistor (PHEMT) chip, which has very low noise figure, high associated gain and high dynamic range. The device can be used in circuits up to 30 GHz and suitable for low noise and medium power amplifier applications including a wide range of commercial and military applications. All devices are 100% DC tested to assure consistent quality. All bond pads are gold plated for either thermo-compression or thermo-sonic wire bonding.

ELECTRICAL SPECIFICATIONS ($T_A=25^\circ C$)

Symbol	Conditions	MIN	TYP	MAX	UNIT
NF	Noise Figure at $V_{DS} = 4$ V, $I_{DS} = 25$ mA, $f = 12$ GHz		0.5	0.7	dB
G_a	Associated Gain at $V_{DS} = 4$ V, $I_{DS} = 25$ mA, $f = 12$ GHz	10	12		dB
P_{1dB}	Output Power at 1dB Gain Compression Point, $f = 12$ GHz $V_{DS} = 6$ V, $I_{DS} = 40$ mA	20.5	21.5		dBm
G_L	Linear Power Gain, $f = 12$ GHz $V_{DS} = 6$ V, $I_{DS} = 40$ mA	11	12		dB
I_{DSS}	Saturated Drain-Source Current at $V_{DS} = 2$ V, $V_{GS} = 0$ V		90		mA
g_m	Transconductance at $V_{DS} = 2$ V, $V_{GS} = 0$ V		100		mS
V_p	Pinch-off Voltage at $V_{DS} = 2$ V, $I_D = 0.6$ mA		-1.0*		Volts
BV_{DGO}	Drain-Gate Breakdown Voltage at $I_{DGO} = 0.15$ mA	9	12		Volts
R_{th}	Thermal Resistance		120		$^\circ C/W$

Note: * For the tight control of the pinch-off voltage. TC1201's are divided into 3 groups:

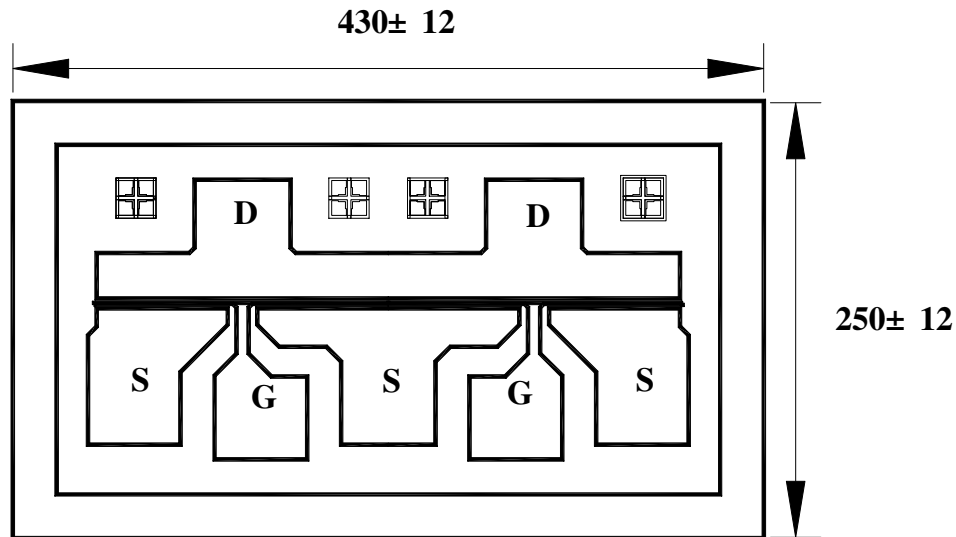
(1) **TC1201P0710** : $V_p = -0.7$ V to -1.0 V (2) **TC1201P0811** : $V_p = -0.8$ V to -1.1 V (3) **TC1201P0912** : $V_p = -0.9$ V to -1.2 V

In addition, the customers may specify their requirements.

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ C$) TYPICAL NOISE PARAMETERS ($T_A=25^\circ C$)

$V_{DS} = 4$ V, $I_{DS} = 25$ mA

Symbol	Parameter	Rating	Frequency (GHz)	NF_{opt} (dB)	G_A (dB)	Γ_{opt}		Rn/50
						MAG	ANG	
V_{DS}	Drain-Source Voltage	7.0 V	2	0.33	20.4	0.89	9	0.66
V_{GS}	Gate-Source Voltage	-3.0 V	4	0.41	17.0	0.80	20	0.46
I_{DS}	Drain Current	I_{DSS}	6	0.45	14.7	0.74	37	0.36
I_{GS}	Gate Current	300 μA	8	0.49	13.0	0.68	57	0.29
P_{in}	RF Input Power, CW	21 dBm	10	0.55	12.0	0.63	77	0.25
P_T	Continuous Dissipation	500 mW	12	0.60	11.3	0.58	95	0.20
T_{CH}	Channel Temperature	175 $^\circ C$	14	0.73	10.7	0.55	112	0.16
T_{STG}	Storage Temperature	- 65 $^\circ C$ to +175 $^\circ C$	16	0.85	10.3	0.51	129	0.11
			18	0.97	9.8	0.50	149	0.09

CHIP DIMENSIONS


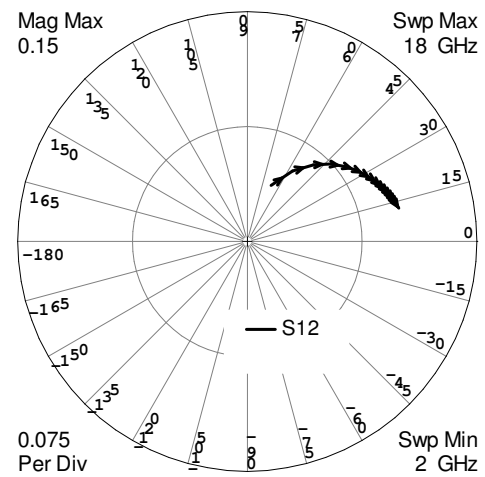
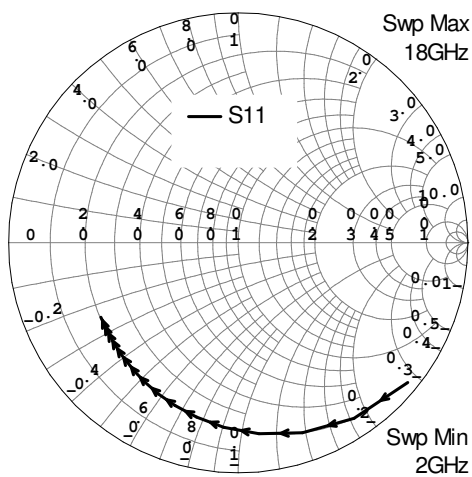
Units: Micrometers

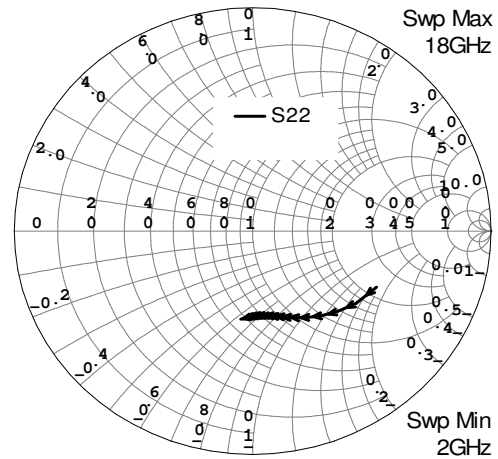
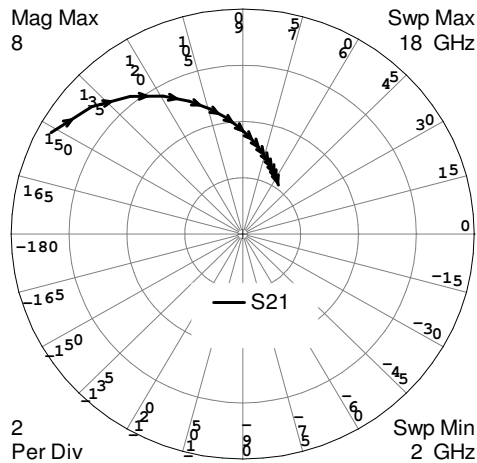
Chip Thickness: 100

Gate Pad: 55 x 50

Drain Pad: 55 x 50

Source Pad: 55 x 65

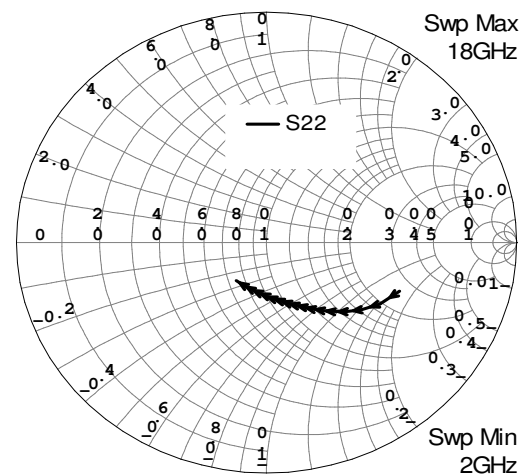
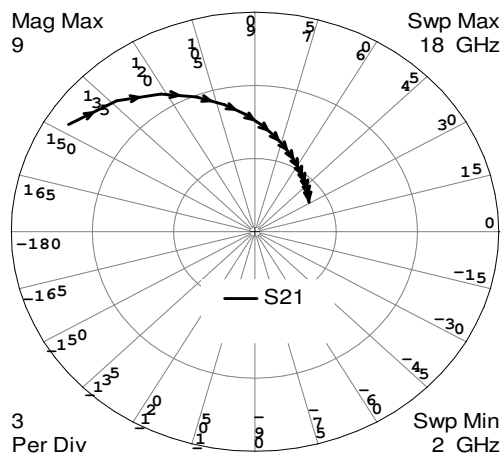
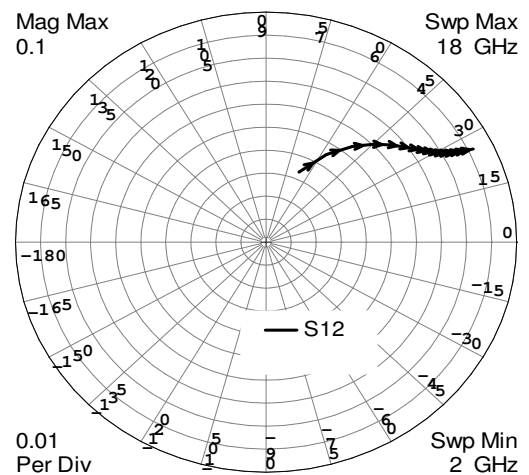
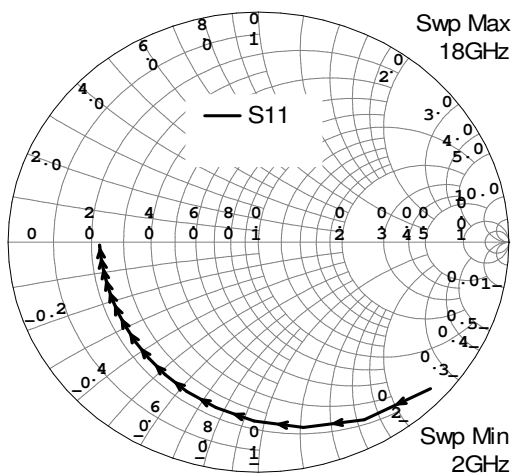
TYPICAL SCATTERING PARAMETERS ($T_A = 25^\circ\text{C}$) $V_{DS} = 4\text{ V}$, $I_{DS} = 25\text{ mA}$




FREQUENCY (GHz)	S11		S21		S12		S22	
	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
2	0.9554	-39.49	7.5329	151.36	0.0398	66.80	0.5775	-25.69
3	0.9139	-56.54	6.9061	139.05	0.0548	57.21	0.5420	-36.51
4	0.8723	-71.28	6.2454	128.40	0.0660	49.27	0.5059	-45.66
5	0.8352	-83.83	5.6234	119.22	0.0743	42.80	0.4737	-53.32
6	0.8042	-94.47	5.0697	111.25	0.0804	37.54	0.4471	-59.75
7	0.7790	-103.50	4.5894	104.26	0.0849	33.23	0.4260	-65.20
8	0.7588	-111.21	4.1772	98.02	0.0883	29.68	0.4100	-69.87
9	0.7425	-117.84	3.8241	92.37	0.0909	26.70	0.3983	-73.94
10	0.7294	-123.59	3.5208	87.18	0.0930	24.17	0.3902	-77.53
11	0.7186	-128.61	3.2590	82.37	0.0947	22.01	0.3851	-80.74
12	0.7098	-133.04	3.0317	77.86	0.0960	20.13	0.3823	-83.64
13	0.7025	-136.97	2.8331	73.59	0.0972	18.48	0.3816	-86.29
14	0.6963	-140.48	2.6586	69.52	0.0982	17.01	0.3826	-88.74
15	0.6911	-143.65	2.5043	65.62	0.0991	15.70	0.3849	-91.01
16	0.6866	-146.51	2.3671	61.87	0.0999	14.51	0.3883	-93.14
17	0.6827	-149.13	2.2444	58.23	0.1006	13.43	0.3928	-95.14
18	0.6793	-151.52	2.1341	54.70	0.1013	12.44	0.3980	-97.05

* The data does not include gate, drain and source bond wires.

TYPICAL SCATTERING PARAMETERS (T_A=25 °C) V_{DS} = 6 V, I_{DS} = 40 mA



FREQUENCY	S11		S21		S12		S22	
(GHz)	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
2	0.9492	-42.63	8.1520	149.89	0.0332	65.82	0.5814	-23.13
3	0.9040	-60.64	7.3895	137.28	0.0452	56.18	0.5443	-32.47
4	0.8603	-75.94	6.6121	126.58	0.0539	48.42	0.5083	-40.13
5	0.8229	-88.76	5.9016	117.51	0.0602	42.29	0.4777	-46.43
6	0.7926	-99.48	5.2840	109.74	0.0648	37.45	0.4535	-51.70
7	0.7685	-108.48	4.7585	102.97	0.0682	33.60	0.4353	-56.23
8	0.7495	-116.10	4.3141	96.97	0.0708	30.49	0.4222	-60.23
9	0.7344	-122.61	3.9377	91.56	0.0728	27.95	0.4133	-63.85
10	0.7224	-128.23	3.6174	86.61	0.0744	25.85	0.4077	-67.19
11	0.7126	-133.13	3.3430	82.03	0.0758	24.09	0.4048	-70.31
12	0.7046	-137.43	3.1063	77.73	0.0770	22.60	0.4040	-73.25
13	0.6979	-141.24	2.9006	73.66	0.0781	21.31	0.4049	-76.05
14	0.6923	-144.65	2.7207	69.79	0.0791	20.19	0.4072	-78.73
15	0.6875	-147.73	2.5622	66.07	0.0799	19.20	0.4106	-81.30
16	0.6833	-150.51	2.4219	62.49	0.0808	18.32	0.4149	-83.76
17	0.6797	-153.06	2.2969	59.03	0.0816	17.53	0.4199	-86.13
18	0.6764	-155.39	2.1849	55.66	0.0824	16.80	0.4255	-88.42

*The data does not include gate, drain and source bond wires.

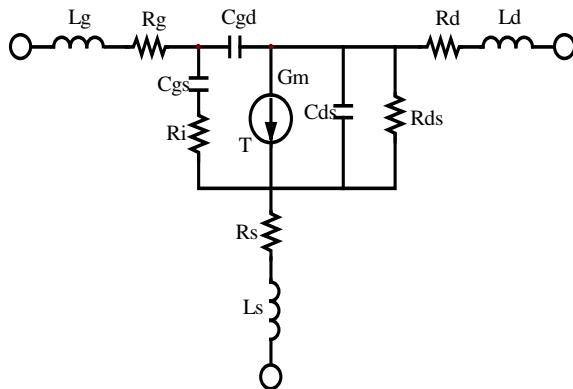
SMALL SIGNAL MODEL, $V_{DS} = 4$ V, $I_{DS} = 25$ mA

TRANSCOM, INC., 90 Dasoong 7th Road, Tainan Science-Based Industrial Park, Hsin-She Shiang, Tainan County, Taiwan, R.O.C.

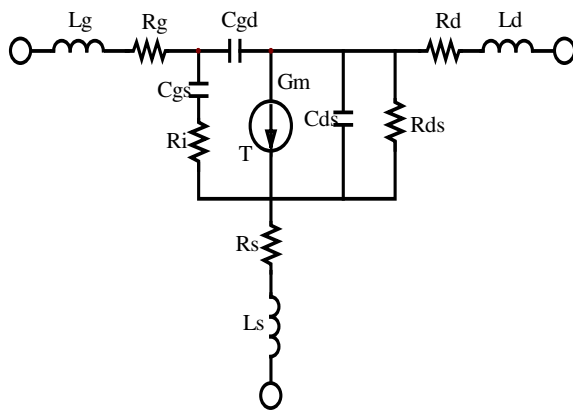
Web-Site: www.transcominc.com.tw

Phone: 886-6-5050086

Fax: 886-6-5051602

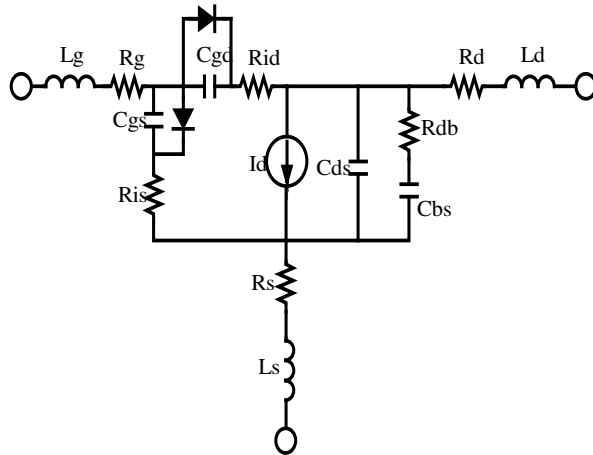
SCHEMATI

PARAMETERS

Lg	0.028 nH	Rs	1.63 Ohm
Rg	2.21 Ohm	LS	0.0005 nH
Cgs	0.425 pF	Cds	0.104 pF
Ri	5.95 Ohm	Rds	172.8 Ohm
Cgd	0.039 pF	Rd	0.898 Ohm
Gm	123.1 mS	Ld	0.024 nH
T	4.58 psec		

SMALL SIGNAL MODEL, $V_{DS} = 6$ V, $I_{DS} = 40$ mA
SCHEMATI

PARAMETERS

Lg	0.028 nH	Rs	1.63 Ohm
Rg	2.21 Ohm	LS	0.0005 nH
Cgs	0.52 pF	Cds	0.1 pF
Ri	7.12 Ohm	Rds	173.9 Ohm
Cgd	0.032 pF	Rd	0.898 Ohm
Gm	136.8 mS	Ld	0.024 nH
T	5.10 psec		

LARGE SIGNAL MODEL, $V_{DS} = 6$ V, $I_{DS} = 40$ mA

SCHEMATIC

TOM2 MODEL PARAMETERS

Parameters		Parameters	
VTO	-0.757 V	VMAX	0.5 V
ALPHA	3.92	CGD	0.032 pF
BETA	0.161	CGS	1.7929 pF
GAMMA	0.0509	CDS	0.097 pF
DELTA	0.3815	RIS	7.121 Ohm
Q	0.987	RID	0.001 Ohm
NG	0.1	VBR	9 V
ND	0.01	RDB	173.9 Ohm
TAU	5.098 ps	CBS	0.0266 pF
RG	2.205 Ohm	TNOM	25 °C
RD	0.898 Ohm	LS	0.0005 nH
RS	1.631 Ohm	LG	0.0278 nH
IS	1E-11 mA	LD	0.0243 nH
N	1	AFAC	1
VBI	1 V	NFING	1
VDELTA	0.2 V		

CHIP HANDLING

DIE ATTACHMENT: Conductive epoxy or eutectic die attach is recommended. Eutectic die attach can be accomplished with Au-Sn (80%Au-20%Sn) perform at stage temperature: 290°C ± 5°C; Handling Tool: Tweezers; Time: less than 1min.

WIRE BONDING: The recommended wire bond method is thermocompression bonding with 0.7 to 1.0 mil (0.018 to 0.025 mm) gold wire. Stage temperature: 220°C to 250°C; Bond Tip Temperature: 150°C; Bond Force: 20 to 30 gms depending on size of wire and Bond Tip Temperature.

HANDLING PRECAUTIONS: The user must operate in a clean, dry environment. Care should be exercised during handling avoid damage to the devices. Electrostatic Discharge (ESD) precautions should be observed at all stages of storage, handling, assembly, and testing. The static discharge must be less than 300V.